



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_{D} = -250 \mu A, V_{GS} = 0 V$		-30			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -30V, V_{GS} = 0V$				-1	۸
			T _J = 55℃			-5	μA
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 16V$				±10	μA
V _{GS(th)}	Gate Threshold Voltage	D0 00 D 1		-0.8	-1.3	-1.6	V
I _{D(ON)}	On state drain current	V_{GS} =-10V, V_{DS} =-5V		-160			А
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =-10V, I_{D} =-17A			5.5	7	
			T_=125℃		7	8.5	m ()
		V _{GS} =-4.5V, I _D =-15A			6.5	8	mΩ
		V_{GS} =-4V, I_{D} =-13A			6.9	9	
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-17A			70		S
V _{SD}	Diode Forward Voltage	$I_{S} = -1A, V_{GS} = 0V$			-0.62	-1	V
I _S	Maximum Body-Diode Continuous Current					-3	А
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz			4580	5500	pF
C _{oss}	Output Capacitance				755		pF
C _{rss}	Reverse Transfer Capacitance				564		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			160	210	Ω
SWITCHI	NG PARAMETERS						
Q _g (-10V)	Total Gate Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-17A			87	105	nC
Q _g (-4.5V)	Total Gate Charge				41		nC
Q_{gs}	Gate Source Charge				12.8		nC
Q_{gd}	Gate Drain Charge				17		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =-10V, V _{DS} =-15V R _L =-0.9Ω, R _{GEN} =3Ω			180		ns
t _r	Turn-On Rise Time				260		ns
t _{D(off)}	Turn-Off DelayTime				1.2		μs
t _f	Turn-Off Fall Time				9.7		μs
t _{rr}	Body Diode Reverse Recovery Time	I _F =-17A, dI/dt=300A/µ	ιs		32	40	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-17A, dI/dt=300A/μs			77		nC

A: The value of R_{eJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}{=}150^\circ\,$ C, using \leqslant 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial T_J = 25° C.

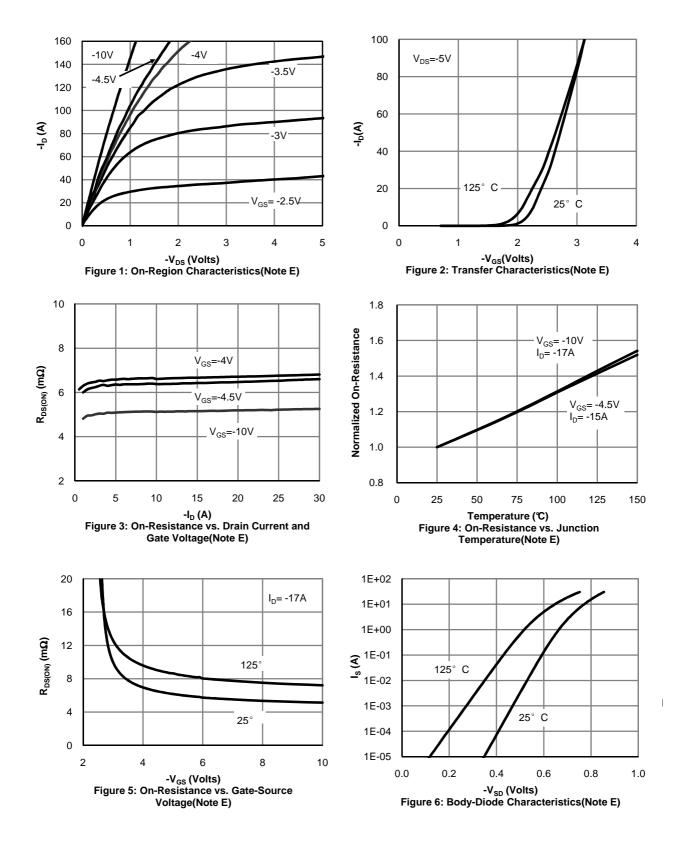
D. The $R_{\rm 0JA}$ is the sum of the thermal impedence from junction to lead $R_{\rm 0JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

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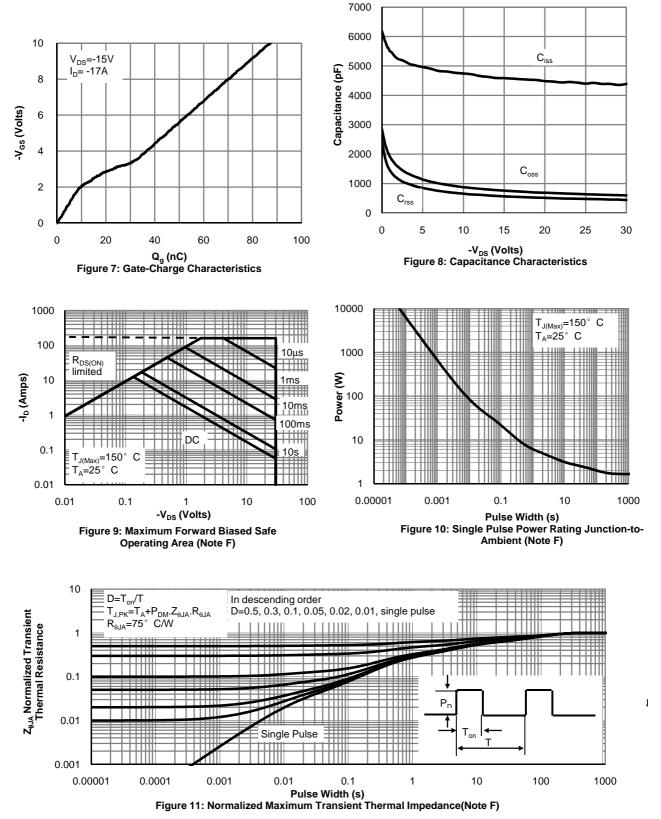


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



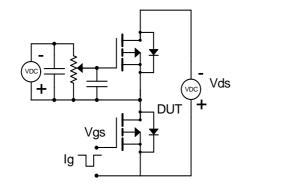


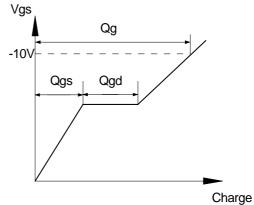
TYPICAL ELECTRICAL AND THERMAL CHARACTER



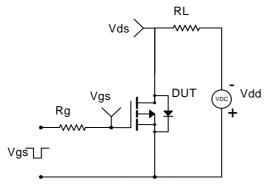


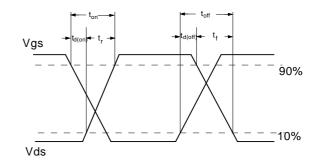
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





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